

<b>Notice of References Cited</b>	Application/Control No. 10/524,216		Applicant(s)/Patent Under Reexamination CHOWDHRY ET AL.	
	Examiner RIP A. LEE		Art Unit 1796	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,737,483	05-2004	Tomov et al.	526/93
	B	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*	N	WO 00/20464	04-2000	International	Tomov et al.	C08F 2/24
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#### NON-PATENT DOCUMENTS

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